

Diagonal 31.9 mm (Type 2.0) CMOS solid-state Image Sensor with Square Pixel for Monochrome Cameras

### Description

The IMX928-AMB is a diagonal 31.9 mm (Type 2.0) CMOS active pixel type solid-state image sensor with a square pixel array and 68 M effective pixels. This chip features a global shutter with variable charge-integration time. This sensor operates with 3.3 V, 2.9 V, 1.1 V, and 1.8 V quadruple power supply. High sensitivity and low dark current characteristics are achieved.

(Applications: FA cameras, 3D vision cameras)

### Features

- ◆CMOS active pixel type dots
- ◆Built-in timing adjustment circuit, H/V driver and serial communication circuit
- ◆Global shutter function
- ◆Input clock frequency 37.125 MHz / 74.25 MHz
- ◆Readout mode
  - All-pixel scan mode, 1/2 subsampling mode
  - H2V2 FD binning mode / H1V2 FD binning mode / H2V1 FD binning mode
  - ROI mode, Vertical / Horizontal - Normal / Inverted readout mode
- ◆Readout rate       (\*) At high frame rates, control so as not to exceed  $T_j = +85\text{ }^{\circ}\text{C}$ 
  - Maximum frame rate in All-pixel scan mode: \*controller mode
  - 8-bit 138.9 frames/s, 10-bit 126.8 frame/s, 12-bit 90.6 frame/s
- ◆Variable-shutter speed
- ◆Pulse Output Function
  - The monitor output for Integration period (TOUT0) and for internal AD period (TOUT1)
- ◆8-bit / 10-bit / 12-bit Output
- ◆CDS / PGC function
  - 0 dB to 24 dB: Variable analog Gain (0.3 dB step)\* 12-bit
  - 24.3 dB to 48 dB: Fixed analog Gain: 24 dB + variable digital Gain: 0.3 dB to 24 dB (0.3 dB step)\*12-bit
  - 0 dB to 18 dB: Variable analog Gain (0.3 dB step)\* 8-bit / 10-bit
  - 18.3 dB to 42 dB: Fixed analog Gain: 18 dB + variable digital Gain: 0.3 dB to 24 dB (0.3 dB step)\*8-bit / 10-bit
- ◆I/O interface
  - SLVS-EC (2 Lane , 4 Lane , 6 Lane , 8 Lane , 4 Lane × 2 , 6 Lane × 2 , 8 Lane × 2 ) output
  - SLVS-EC Baud Rate: 4.752 Gbps / lane 9.504 Gbps / lane 12.474 Gbps / lane (Grade 3, 4 and 5)
- ◆CRA characteristics: The target CRA is 6 degrees at 100% image height.
- ◆Ceramic package with connector. The connector is floating type.
- ◆Seal glass: both sides are processed by AR coating

## Device Structure

◆ CMOS image sensor		
◆ Image size	Diagonal 31.9 mm (Type 2.0)	Approx. 68.55 M pixels
◆ Total number of pixels	8280 (H) × 8376 (V)	Approx. 69.35 M pixels
◆ Number of effective pixels	8280 (H) × 8280 (V)	Approx. 68.55 M pixels
◆ Number of active pixels	8256 (H) × 8256 (V)	Approx. 68.16 M pixels
◆ Number of recommended recording pixels	8248 (H) × 8248 (V)	Approx. 68.02 M pixels
◆ Unit cell size	2.74 μm (H) × 2.74 μm (V)	
◆ Optical black	Horizontal (H) direction: Front 0 pixel, rear 0 pixel Vertical (V) direction: Front 20 pixels, rear 0 pixel	
◆ Package	Ceramic package with connector 160 pin × 2	45 mm (H) × 52 mm (V)

## Basic Drive Mode

Drive mode	Recommended number of recording pixels	Maximum frame rate [frame/s]	Output interface	Output [bit]
All-pixel (Controller mode)	8248 (H) × 8248 (V) Approx. 68.02 M pixels	138.9	SLVS-EC 8 × 2 Lane	8
		126.8		10
		90.6		12
H2V2 FD binning 1/2 subsampling	4124 (H) × 4124 (V) Approx. 17.00 M pixels	271.4	SLVS-EC 8 × 2 Lane	8
		248.3		10
		178.3		12

Note: All frame rates are tentative.

## Pregius S

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